

WHAT IS CLAIMED IS

1. A semiconductor integrated circuit,
5 comprising:
 a shielded wire line; and
 a shielding wire line provided for the
shielded wire line and having a width broader than
that of the shielded wire line.
10
2. A semiconductor integrated circuit,
15 comprising:
 a shielded wire line; and
 a plurality of shielding wire lines
provided for the shielded wire line on one side of
the shielded wire line.
20
3. A semiconductor integrated circuit,
25 comprising:
 a shielded wire line; and
 a shielding wire line provided along only
a portion of an entire extent of the shielded wire
line.
30
4. The semiconductor integrated circuit
35 as claimed in claim 3, further comprising a driver
that transmits a signal to the shielded wire line,
wherein the portion of the entire extent of the

shielded wire line along which the shielding wire line is provided is a portion on a side of the driver.

5

5. A method of determining wire lines of a semiconductor integrated circuit, comprising the steps of:

- 10 providing as a library, shielding effects of partial shielding that shields only a portion of an entire extent of a shielded wire line;
 determining a length of the shielded wire line;
15 determining a desired shielding effect;
and
 determining a length of a shielding wire line by looking up the length of the shielded wire line and the desired shielding effect in the
20 library.

- 25 6. The method as claimed in claim 5, wherein the step of providing as a library the shielding effects of partial shielding provides, as the library, information about signal delay time that appears when a portion of the entire extent of
30 the shielded wire line is shielded.